Notice of References Cited	Application/Control No. 10/577,111	Applicant(s)/Patent Under Reexamination IMAI ET AL.		
	Examiner	Art Unit		
	SHIN-HON CHEN	2431	Page 1 of 1	

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0158708	08-2004	Peyravian et al.	713/156
*	В	US-6,061,799	05-2000	Eldridge et al.	726/20
	U	US-			
	ם	US-			
	ш	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	7	US-			
	K	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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	V		
	w		
	х		

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